

## Special Issue

# Latest Applications of Laser Measurement Technologies

### Message from the Guest Editor

Laser measurement technologies are widely used for the online measurements of physical, biological, and chemical quantities. In recent years, laser measurement technologies have undergone rapid development because of the emergence of advanced light source and detection strategies. Laser measurement technologies have been adopted in many applications, such as environmental monitoring, industrial processes, image diagnosis, and planetary exploration. The most prominent feature of laser measurement technologies is that the measurement is conducted without contact and the speed is ultrafast because of the characteristics of light. Furthermore, the precision of laser-based measurement is attractive. Up until now, various laser measurement methods have been successfully invented for a variety of measuring tasks. In this Special Issue, papers about laser measurement techniques, especially about the current state-of-the-art methods, are welcomed; review articles are also encouraged. Potential topics include, but are not limited to, the following: Laser sensing; Laser imaging; Laser diagnostics; Laser lidar; Laser spectroscopy; Laser sources; Laser technology.

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### Guest Editor

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### Deadline for manuscript submissions

20 September 2026



## Applied Sciences

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Impact Factor 2.5  
CiteScore 5.5



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### Editor-in-Chief

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